

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10549451	HAYASHI, KENJI
	Examiner	Art Unit
	PHUC H TRAN	2416

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Text search for interference	12/18/08	p.t
Consulted with Steven Nguyen	12/17/08	p.t

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	see history printout	12/18/08	p.t

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